

Docket Number: 081468-0307474

Client Reference: P-1796.000-US



PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In Re the Application of

MARK KROON, et al.

Group Art Unit: 2851

Application No.: 10/748,751

Examiner: Peter B. Kim

Filed: December 31, 2003

Confirmation No.: 2729

For: LITHOGRAPHIC APPARATUS, DEVICE MANUFACTURING METHOD, AND DEVICE
MANUFACTURED THEREBY

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P. O. Box 1450
Alexandria, VA 22313-1450

Sir:

Pursuant to 37 CFR 1.56, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached PTO-1449. One copy of each reference is attached. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the references be made of record therein and appear among the "References Cited" on any patent to issue therefrom. Applicants respectfully request the Examiner return an initialed copy of the enclosed Form PTO-1449 to Applicants with the next Office communication to indicate that the references have been considered, per MPEP § 609.

This Information Disclosure Statement is being filed with a Request for Continued Examination.

The patent references were cited in a counterpart foreign application. An English language version of the International Search Report is attached for the Examiner's information. Applicants note that U.S. Patent No. 5,696,623 is already of record.

Respectfully Submitted,

Emily T. Bell
Registration Number 47418
Customer Number: 00909

Date: March 23, 2006
PILLSBURY WINTHROP SHAW PITTMAN LLP
Telephone: (703) 770-7900
Facsimile: (703) 770-7901
P.O. Box 10500
McLean, VA 22102



Atty.
Dkt. No.

M#

Client Ref.

307474

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

Applicant: KROON et al.

Appln. No.: 10/748,751

Filing Date: December 31, 2003

Date: March 23, 2006

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of

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Examiner: Peter B. Kim

Group Art Unit: 2851

U.S. PATENT DOCUMENTS

Examiner's Initials*	Document Number	Date MM/YYYY	Name (Family Name of First Inventor)	Class	Sub Class	Filing Date (if appropriate)
	AR					
	BR					
	CR					
	DR					
	ER					
	FR					
	GR					
	HR					
	IR					
	JR					
	KR					
	LR					
	MR					
	NR					

FOREIGN PATENT DOCUMENTS

	Document Number	Date MM/YYYY	Country	Inventor Name		English Abstract		Translation Readily Available	
						Enclosed	No	Enclose	No
	OR	1 526 550 A1	04/2005	Europe	ASML Netherlands B.V.				
	PR	1 037 036 A1	09/2000	Europe	Trace Analytical				
	QR	0 874 283 A3	01/2000	Europe	Nikon Corporation				
	RR	0 874 283 A2	10/1998	Europe	Nikon Corporation				
	SR	0 706 042 A1	04/1996	Europe	Nippon Sanso Corporation				
	TR								
	UR								
	VR								
	WR								
	XR								

OTHER (Including in this order Author, Title, Periodical Name, Date, Pertinent Pages, etc.)

YR	International Search Report issued for PCT Application PCT/NL2004/000927 on December 19, 2005.			
ZR				
AAR				
BBR				
CCR				

Examiner

Date Considered:

*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.